Onsemi

MOSFET – P-Channel, **QFET**

-150 V, -3 A, 1.5 Ω

FDMC2523P

General Description

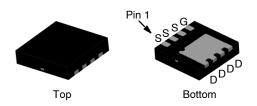
These P-Channel MOSFET enhancement mode power field effect transistors are produced using onsemi's proprietary, planar stripe, DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for low voltage applications such as audio amplifier, high efficiency switching DC-DC converters, and DC motor control.

Features

- Max $R_{DS(on)} = 1.5 \Omega$ at $V_{GS} = -10 V$, $I_D = -1.5 A$
- Low C_{rss} (Typical 10 pF)
- Fast Switching
- Low Gate Charge (Typical 6.2 nC)
- Improved dv / dt Capability
- This Device is Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

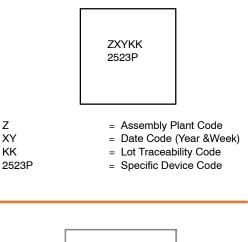
Applications

• Active Clamp Switch

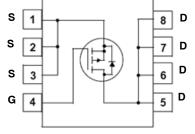


WDFN8 3.3x3.3, 0.65P CASE 511DH

MARKING DIAGRAM



Ζ



ORDERING INFORMATION

Device	Package	Shipping †
FDMC2523P	WDFN8 (Pb–Free)	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

MOSFET MAXIMUM RATINGS (T_A = 25° C unless otherwise noted)

Symbol		Parameter				
V _{DS}	Drain to Source Voltage	-150	V			
V _{GS}	Gate to Source Voltage		±30	V		
ID	Drain Current	Continuous	T _C = 25°C	-3	А	
		Continuous	T _C = 100°C	-1.8		
		Pulsed	-	-12		
PD	Power Dissipation (Stead	42	W			
E _{AS}	Single Pulse Avalanche Energy (Note 5)			3.3	mJ	
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to +150	°C	
ΤL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds			300	°C	
dv/dt	Peak Diode Recovery dv	/dt (Note 2)		-5	V/ns	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case (Note 1)	3.0	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)	60	

ELECTRICAL CHARACTERISTICS (T_J = $25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Parameter Test Conditions		Тур	Max	Unit
OFF CHARA	CTERISTICS					-
BV_DSS	Drain-to-Source Breakdown Voltage	I_D = -250 μ A, V _{GS} = 0 V	-150	-	-	V
$\frac{\Delta \text{BV}_{\text{DSS}}}{\Delta \text{T}_{\text{J}}}$	Breakdown Voltage Temperature Coefficient	$I_D = -250 \ \mu$ A, referenced to 25°C	-	-138	-	mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -150 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	-1	μΑ
		V_{DS} = –150 V, V_{GS} = 0 V, T_J = 125 $^\circ C$	-	-	-10	μΑ
I _{GSS}	Gate-to-Source Leakage Current	$V_{GS}=\pm30~\text{V},~\text{V}_{DS}=0~\text{V}$	-	-	±100	nA
			1	1	1	

ON CHARACTERISTICS

V _{GS(th)}	Gate-to-Source Threshold Voltage	V_{GS} = V_{DS} , I_D = -250 μA	-3	-3.8	-5	V
$\frac{\Delta V_{\text{GS(th)}}}{\Delta T_{\text{J}}}$	Gate-to-Source Threshold Voltage Temperature Coefficient	$I_D = -250 \ \mu A$, referenced to $25^{\circ}C$	-	6	-	mV/°C
R _{DS(on)}	Static Drain-to-Source	$V_{GS} = -10 \text{ V}, \text{ I}_{D} = -1.5 \text{ A}$	-	1.1	1.5	Ω
	On Resistance	V_{GS} = -10 V, I _D = -1.5 A, T _J = 125°C	-	2.0	3.6	
9fs	Forward Transconductance	$V_{DS} = -40 \text{ V}, I_D = -1.5 \text{ A} \text{ (Note 4)}$	-	1.4	-	S

DYNAMIC CHARACTERISTICS

C _{iss}	Input Capacitance	V_{DS} = -25 V, V_{GS} = 0 V, f = 1 MHz	-	200	270	pF
C _{oss}	Output Capacitance		-	60	80	
C _{rss}	Reverse Transfer Capacitance		-	10	15	
Rg	Gate Resistance	f = 1 MHz	0.1	7.5	15	Ω

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit		
SWITCHING CHARACTERISTICS								
t _{d(on)}	Turn-On Delay Time	$V_{DD} = -75 \text{ V}, \text{ I}_{D} = -3 \text{ A}, \text{ V}_{GS} = -10 \text{ V},$	-	15	27	ns		
t _r	Rise Time	$R_{GEN} = 25 \Omega$ (Note 3, 4)	-	11	20			
t _{d(off)}	Turn-Off Delay Time		-	19	35			
t _f	Fall Time		-	13	24			
Qg	Total Gate Charge	$V_{GS} = -10 \text{ V}, V_{DD} = -75 \text{ V}, I_D = -3 \text{ A}$	-	6.2	9	nC		
Q _{gs}	Gate-to-Source Charge	(Note 3, 4)	-	1.4	_			
Q _{gd}	Gate-to-Drain "Miller" Charge		-	3.3	-			

DRAIN-SOURCE DIODE CHARACTERISTICS

ا _S	Maximum Continuous Drain – Source Diode Forward Current		-	-	-3	А
I _{SM}	Maximum Pulse Drain - Source Doide Forward Current		-	-	-12	
V _{SD}	Source-to-Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, \text{ I}_{S} = -3.0 \text{ A}$	-	-1.8	-5	V
t _{rr}	Reverse Recovery Time	I_F = –3.0 A, di/dt = 100 A/ μs (Note 3)	-	93	-	ns
Q _{rr}	Reverse Recovery Charge		-	0.27	-	μC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

NOTES:

1. R_{0JA} is the sum of the junction-to-case and case-to- ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{BJC} is guaranteed by design while R_{BCA} is determined by the user's board design.



a) $60^{\circ}C/W$ when mounted on a 1 in² pad of 2 oz copper



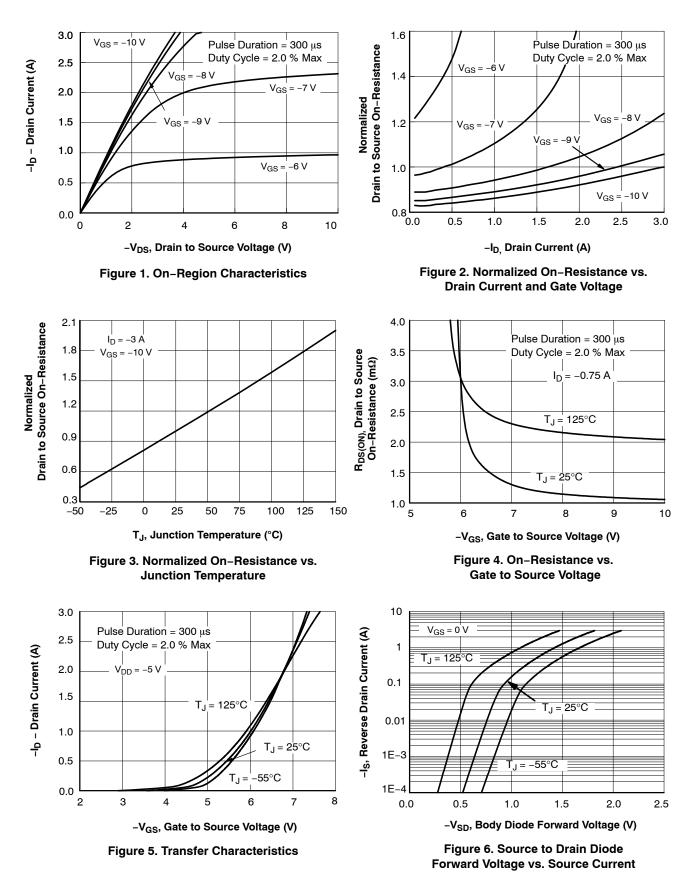
b) $135^{\circ}C/W$ when mounted on a minimum pad of 2 oz copper

- $\begin{array}{ll} \text{2.} \quad I_{SD} \leq -3 \text{ A}, \ dl/dt \leq 300 \ \text{A}/\mu\text{s}, \ V_{DD} \leq B_{VDSS}, \ \text{Starting } T_J = 25^\circ\text{C}. \\ \text{3.} \quad \text{Pulse Test: Pulse Width } < 300 \ \mu\text{s}, \ \text{Duty cycle} < 2.0\%. \\ \text{4.} \quad \text{Essentially independent of operating temperature.} \end{array}$

- 5. E_{AS} of 3.3 mJ is based on starting $T_J = 25^{\circ}C$, P-ch: L = 3 mH, $I_{AS} = -1.5$ A, $V_{DD} = -150$ V, $V_{GS} = -10$ V.

TYPICAL CHARACTERISTICS

(T_J = 25°C unless otherwise noted)



TYPICAL CHARACTERISTICS (continued)

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$

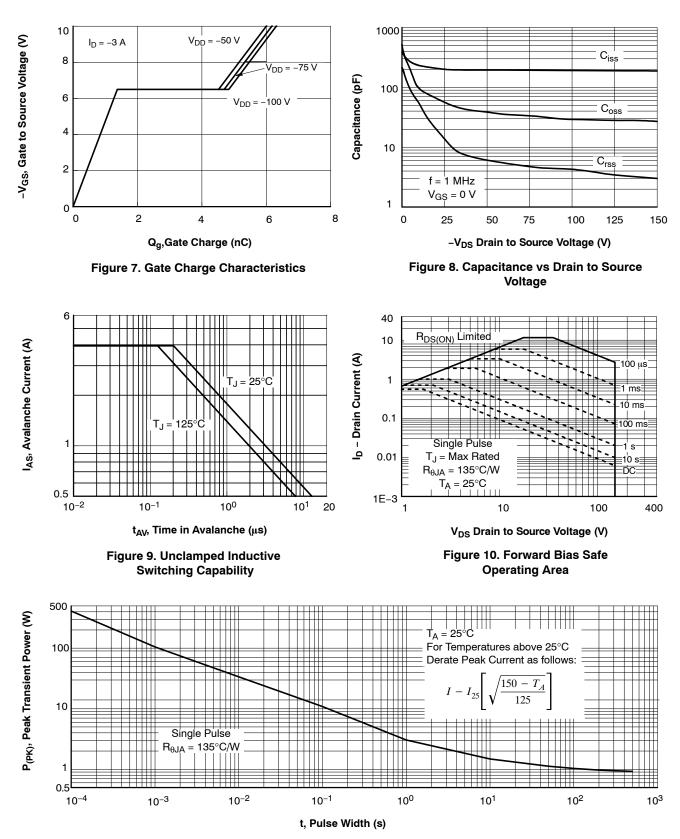


Figure 11. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS (continued)

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$

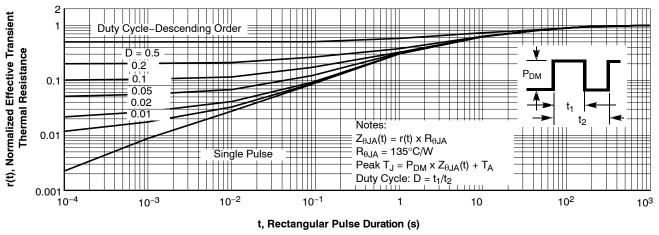
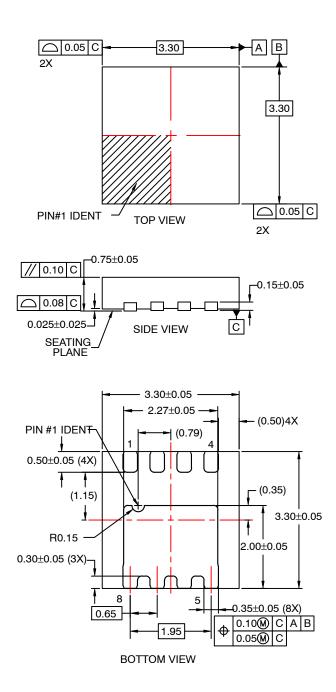


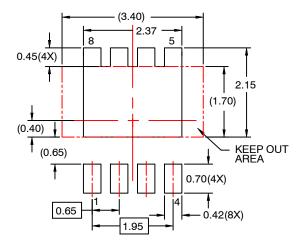
Figure 12. Transient Thermal Response Curve



WDFN8 3.3x3.3, 0.65P CASE 511DH ISSUE O

DATE 31 JUL 2016





RECOMMENDED LAND PATTERN

NOTES:

- A. DOES NOT CONFORM TO JEDEC REGISTRATION MO-229
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN.

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